		Application/Control No.	Applicant(s)/Patent Under Reexamination
Notice of References Cited		10/782,142	CAMERON ET AL.
		Examiner	Art Unit	Page 1 of 1
		Shelly A. Chase	2133	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Mao et al., A new schedule for decoding low density parity check codes, 2001, IEEE, pg. 1007-1010.
	V	Xiao-Yu et al., Efficient implementations of the sum-product algorithm for decoding LDPC codes, 2001, IEEE, pg. 1036-1036E.
	W	Achilleas Anastasopoulos, A comparison between the sum-product and the min-sum iterative detection algorithms based on density evolution, 2001, IEEE, pg. 1021-1025.
	X	Xiao-Yu et al., Progressive edge-growth Tannar graph, 2001, IEEE, pg. 995-1001.

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.